Major Research Facilities

Facility	Make/Model
All Common Facilities of the Centre are	
used by AKR aroun for details see the link	
used by Airth group for details see the link	
<u>www.bose.res.in/~lechnicaiceii</u>	
Special sophisticated experimental facilities in	
AKR group	
1. Low frequency noise	Assembled around lock-in amplifier can
measurement (temperature	measure resistances down to nanoohm. This
variable) down to a noise floor of	has a special soft-ware written by the
10 ⁻²¹ V ² /Hz and with variable	group. It is very fare facility in the country
temperature facility down to 77K	
2. 1.5K, 10T GM cycle based system	The measurement system (fully automated)
for transport, magnetic and	has been assembled around the cryostat by
dielectric measurements.	
3. Photo-conductivity	Measurements of Photoconductivity in
measurements	nanowires and films are done in a nome made apparatus that uses a small LIV
	source. A variable frequency measurement
	set-up built around a monochromator has
	been innovated around the PL set-up of the
A LIUV tomporature variable	CENTRAL IACHITY.
4.011 v temperature variable Scanning probe microscope with	is a combination of Scanning Tunneling
maanetic field	Microscope (STM) and Atomic Force
magnetic pera.	Microscope (AFM) which works in a UHV
	atmosphere of better than 10 ⁻¹⁰ torr and can
	800K.
5. Potentiostat and	CHI- This unit is widely used for
Electrochemical deposition unit	synthesizing metal nanowires in
	nanoporous templates using
6 Wet-chemical laboratory	AKR group uses extensive chemical routes
including sample heat treatments	for sample preparation. Almost all the
upto 1300C	samples used in the experimental work are
	synthesized in-house by AKR group.

Facilities in the clean room

AKR group has a dedicated clean room facility (class 1000+) that is used in its nanofabrication work. The facility houses a combination of optical lithography, electron-beam facility and focused ion beam nanolithography tools that allows extensive nanodevice fabrication. At present the group can fabricate devices based on single nanowires with diameter as low as 20nm or create patterns using the focused ion beams with feature sizes down to 20nm

Helios 600 dual beam machine	This machine is a combination of focused ion beam (FIB), electron beam (FEG-SEM) and localized precursor based deposition unit. The ion beam and electron beam writing as well as metal deposition can be done using a CAD based pattern generator . The machine is extensively used for lift-off based nanolithography and allows sub- 100nm pattern creation
Mask – aligner (EMA-400)	The mask-aligner is used for optical lithography work for pattern generations down to 5μm.
ICP-RIE Plasma etching unit SENTECH 500	Under installation
UHV metallization unit SVT	Under installation